

Search Notes	Application/Control No. 10540658	Applicant(s)/Patent Under Reexamination MATHIES ET AL.
	Examiner Young J Kim	Art Unit 1637

SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES

Search Notes	Date	Examiner
Patent Databases (USPT, USPPGP, EPO, JPO, DERWENT, IBM-TDB)	2/8/2008	/YJK/
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INTERFERENCE SEARCH

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